

Interference Search  
**EAST Search History**

8/23/06 7:22

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	((detect\$3 sens\$3) and (xray x-ray x adj ray) and (transparent translucent clear) and (layer film coating) and (electrode contact) and (bias\$3 voltage) and ((signal with process\$3) asic (application with specific with (ic circuit))) and (support\$3) and (substrate wafer support layer) and (graphite)).clm.	US-PGPUB	OR	ON	2006/08/23 15:58
L2	2	((detect\$3 sens\$3) and (xray x-ray x adj ray) and (layer film coating) and (electrode contact) and ((direct with (convert\$3 conversion)) scintillat\$3 semiconductor semi-conductor semi adj conductor) and ((signal with process\$3) asic (application with specific with (ic circuit))) and (support\$3) and (substrate wafer support layer) and (graphite)).clm.	US-PGPUB	OR	ON	2006/08/23 16:00
L3	1	((detect\$3 sens\$3) and (xray x-ray x adj ray) and (layer film coating) and (electrode contact) and ((direct with (convert\$3 conversion)) scintillat\$3 semiconductor semi-conductor semi adj conductor) and ((signal with process\$3) asic (application with specific with (ic circuit))) and (support\$3) and (substrate wafer support layer) and connect\$3).clm.	US-PGPUB	OR	ON	2006/08/23 16:01
L4	1	((low with profile) and (detect\$3 sens\$3) and (xray x-ray x adj ray) and (layer film coating) and (electrode contact) and (ct (computed adj tomograph\$1)) and ((signal with process\$3) asic (application with specific with (ic circuit))) and (interpos\$3 support\$3) and (substrate wafer support layer) and connect\$3).clm.	US-PGPUB	OR	ON	2006/08/23 16:03
L5	4	((detect\$3 sens\$3) and (xray x-ray x adj ray) and (layer film coating) and (electrode contact) and (ct (computed adj tomograph\$1)) and ((signal with process\$3) asic (application with specific with (ic circuit))) and (interpos\$3 support\$3) and (substrate wafer support layer)).clm.	US-PGPUB	OR	ON	2006/08/23 16:03

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	8	("5179284" "5847499" "6075248" "6522715" "6635860" "6667482" "0070343").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/08/23 15:35
S2	254	((DAVID) near2 (HOFFMAN)).INV.	US-PGPUB; USPAT; USOCR	OR	ON	2006/08/23 15:25
S3	948811	@pd>="20060228"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:26
S4	3130	(250/370.09 250/370.11 250/370.12 250/370.13 250/363.04 378/11 378/19).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:26
S5	220	S3 and S4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:35
S6	2629	(250/370.01 250/370.08 250/361R 250/363.02).ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:27
S7	34	(detect\$3 sens\$3) and (xray x-ray x adj ray) and (electrode contact) and S6 and S3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:35
S8	86353	(end with block with support\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:28

## EAST Search History

S9	324724	(xray x-ray x adj ray)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:28
S10	5226421	detect\$3 sens\$3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:29
S11	6245712	layer film coating	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:29
S12	5893607	electrode contact	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:29
S13	1134660	(signal with process\$3) (asic) (application with specific with (ic integrated adj circuit))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:30
S14	8371525	substrate support wafer layer	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:29
S15	52383	((computed adj tomograph\$1) (ct)). detd.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:30

## EAST Search History

S17	78234	scintillat\$3 (direct adj (conversion convert\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:31
S18	9268412	connect\$3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:33
S19	1	S8 and (S9 with S10) and S11 and (S12 same S17)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:52
S20	245	(S9 and S10 and S11 and S12 and S13 and S14 and S15 and S17) and ("250" "378").clas.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:52
S21	317	(S9 with S10) and (S11) and (S12 same S17) and S13 and (S14 same S18)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:35
S22	0	("2005/0061985").URPN.	USPAT	OR	ON	2006/08/23 15:42
S23	33	S20 and S3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:52
S24	34	S21 and S3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:52

## EAST Search History

S25	29	S24 not S23	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/23 15:55
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